A Quantum theory of the scattering of soft x-ray from Compton effect caused electron standing wave in the materials

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Abstract

In the present investigation, low-energy x-rays (< 15 keV) scattered from powder, polymer, crystals and hydrogenous liquids (with preference for materials of low binding energy) at different scattering angles have been analysed. The scattered x-rays show unambiguous existence of a new modified line along with unmodified and Compton line. Since, the experimental observation of the inverse Doppler effect, i.e. increase of frequencies of reflecting waves from a receding boundary, has already been reported [Seddon and Bearpark (2003) Science, 302, 1537–1540]. Hence, it is quite logical to think that x-rays may also gain energy in contrast to Compton effect (where they lose energy) in material medium. Such type of new modified x-ray scattering (angle dependent) was observed. Expressions for photon of enhanced energy, $\omega^3$, initial momentum of plasmon $q'$ and the total scattering cross section $\sigma_N$ of this new phenomenon have been derived. The $\sigma_N$ is found out to be proportional to $\sqrt{\varepsilon}$ and is about 100 times less than the Compton cross section using high-energy x-ray photon (100's of keV), usually used for Compton scattering studies. Both theoretically calculated and experimentally observed data match well with one another. The new modified line is to be clearly expected from materials of low atomic number with high dielectric constant using low-energy x-rays.

Key Words: X-ray scattering, Compton effect, plasmon excitation, inverse Doppler effect

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1. Introduction

Discovered in 1921, Compton scattering [1] is used to measure the electron momentum distribution of atoms [2–8]. Subsequently, Smekal-Raman [9, 10] and plasmon scattering [11] were discovered. Moreover, Stokes and anti-Stokes lines were observed using both light and x-rays [12]. A number of good works on incoherent scattering of radiation by plasma have already been reported by various authors [13–20]. Existence of inverse Compton [21, 22], virtual Compton [23], magnetic Compton [24], double Compton [25], and resonant Compton
scattering were reported. Experimental verification of inverse Doppler effect has been reported recently in 2003. Electrons, protons, and neutrons used as a probe instead of photons in Compton scattering have also been reported. As nature loves symmetry, it is quite logical to think that x-rays may also exhibit inverse Doppler effect, where they gain energy in contrast to Compton effect (where they lose energy) in material medium. Non-observance of this type of incoherent scattering peak in the earlier Compton scattering experiments may be due to the following reasons: (i) most of the earlier Compton scattering work was restricted to relatively hard radiation and large scattering angle; (ii) the plasmon excitation in Compton scattering was discovered nearly 50 years after the discovery of Compton scattering; (iii) the damping of the plasmon increases with momentum transfer \( k = (4\pi/\lambda) \sin \theta \) \cite{11}, which is directly proportional to radiation energy and scattering angle; (iv) intensity ratio of the new incoherent peak with unmodified peak was a few tens of times less than the intensity ratio of Compton peak with unmodified peak; (v) sample gets heated due to long exposure to x-ray and the Compton peak decreases slightly when this temperature increases, hence the new peak intensity decreases \cite{41}; (vi) the new scattering was masked by Compton tail of the neighbouring incident x-ray line, spurious peaks, and peak due to source fluctuation; (vii) most of the earlier workers were interested in low-energy side (Compton region) of the unmodified peak; and (viii) the number of photons emitted per second was much less in x-ray sources used in earlier experiments \cite{42}. Thus, the observation of inverse Doppler effect in x-ray was completely sidetracked.

A few years ago, the author observed the scattered x-rays of enhanced energy from solid polymer and suggested that it is because of collision of incident photons with Compton recoil electrons (classical treatment) \cite{43–45}. However, it was not clear in those days; the reason may be lack of negative refractive index concepts in the scattering. However, recent, experiments have shown the existence of such type of incoherent scattering which matches well with the predicted quantum mechanical model.

Schrödinger in 1927 formulated a wave-mechanical model using simple de Broglie’s concepts of matter waves for the Compton scattering \cite{46}, which leads precisely to the same result for the change in wavelength of scattered x-rays as that derived on the theory of impact between photon and free electron by Compton. This quantum mechanical theory doubtlessly gives a more adequate picture of the wavelength change as follows. Consider a new coordinate system where impact of photon and electron are symmetrical both before and after the collision. If \( v \) is the velocity of the electron’s recoil \( (v << c) \) in the fixed co-ordinate, then the required velocity of the moving coordinate is \( v/2 \). At the impact, the momentum of the electron then changes from \(-mv/2\) to \(+mv/2\) as expressed in the moving system, while Y-component of the photon’s momentum changes from \(+h/\lambda \sin \theta\) to \(-h/\lambda \sin \theta\). Thus, the condition for the momentum conservation \cite{46} gives

\[
-(m_0v/2) + (h/\lambda) \sin \theta = (m_0v/2) - (h/\lambda) \sin \theta
\]  

(1)

\[
(2h/\lambda) \sin \theta = m_0v.
\]  

(2)

Thus the energy remains unchanged after impact. Applying Schrödinger and de Broglie hypothesis, the incident electron can be represented by a continuous train of \( \psi \) waves of wavelength \( \lambda_{\text{matter}} = h/(m_0v/2) \) moving along negative y-direction and the recoil electron (atomic) by a similar train of the same wavelength moving along positive y-direction, the two trains together will form standing waves for which the electronic charge density is proportional to \( \psi_{\text{inc}} \psi_{\text{rec}}^* \) and for which the distance from the node to node is \( (\lambda_{\text{matter}}/2) = h/(m_0v) \). The de Broglie waves representing the electron thus form a Bragg grating space \( d = h/(m_0v) \). This grating will diffract the incident x-ray waves according to the usual expression \(-2d \sin \theta = \lambda\). The diffracted waves are modified in
wavelength by the deflection because the grating is in motion, thus resulting in a Doppler effect. Considering the fixed coordinate system as in Figure 1(a), the grating of stationary de Broglie waves is receding from O with velocity \( v/2 \). Treating grating as a mirror, this is equivalent to receiving the light from a virtual image of the source S that recedes from S with velocity \( v \). According to the Doppler’s principle, the modified wavelength emitted from S and reaching P can be written as \( \lambda' = \lambda(1 + (v/c) \sin \theta) \). Substituting the value of \( v \) from equation (2), the increase in wavelength can be simplified as

\[
\Delta \lambda' = (2h/mc) \sin^2 \theta = (h/m_0c) \left(1 - \cos 2\theta\right)
\]

which is exactly the same expression as that obtained from photon theory given by Compton and is known as Compton shift, where \( 2\theta \) is the scattering angle.

Figure 1. Schematic diagram of. (a) collision of a photon and electron (or plasmon) in normalized coordinates, (b) diffraction of incident waves from the standing wave pattern due to incident electron (\( d = h/(mv) \)) or plasmon (\( d' = h/(m'v') \)) and recoil electrons. The incident wave diffracted from the normal dispersion media (\( v_{\text{group}} \) and \( v_{\text{phase}} \) are parallel, positive refractive index) due to incident electron standing wave shows scattered wave of lower frequency. Again, incident wave diffracted from the anomalous dispersive media (\( v_{\text{group}} \) and \( v_{\text{phase}} \), are anti-parallel, negative refractive index) due to incident plasmon standing wave possesses scattered wave of higher frequency.

2. Hypothesis

Substances with negative permittivity \( \varepsilon \) and permeability \( \mu \) have some properties which differ from those of substances with positive \( \varepsilon \) and \( \mu \). In solid-state plasmas (\( \varepsilon < 0, \mu > 0 \)), the square of the refractive index (RI), i.e. \( n^2 \) becomes negative, which leads to reflection of waves from such a medium [47]. Again, due to plasmon excitation in the solid because of Compton effect, material behaves as a metamaterial. The plasmon frequency can be defined as \( \omega_p^2 = e^2 n_e / (\varepsilon_0 \ m^*) \), where \( n_e \) is the electron density (electrons/cm\(^3\)), \( e \) is the electronic charge, \( \varepsilon_0 \) is the permittivity of free space (dielectric constant) and \( m^* \) is the effective mass of electron. The total number of electrons \( N_e \) in the target can be defined as \( N_e = \pi \left(\frac{d}{2}\right)^2 l \ \rho \ \frac{N_A}{A} Z \), where \( d \) is the diameter of target, \( l \) is the length of the target (length of the target intercepted by the beam), \( \rho \) is
the density of the target material, \( N_A \) is the Avogadro’s number (6.023 \times 10^{23}) \footnote{\textit{MALLICK}} \footnote{\textit{MALLICK}}, \( A \) is the atomic weight of the target element and \( Z \) is the atomic number of the element \footnote{\textit{MALLICK}}.

Again, the critical electron density \footnote{\textit{MALLICK}} is defined as \( n_e = \varepsilon_0 m_e^* \omega^2 / e^2 \). However, dielectric function \footnote{\textit{MALLICK}} or permittivity of the medium is usually expressed as \( \varepsilon(\omega) = 1 - (\omega_p^2 / \omega^2) \), whence using the value of \( \omega^2 \), critical plasmon density can be simplified in terms electron density as

\[
n_e = \frac{\varepsilon_0 m_e^* \omega^2}{e^2} \left( 1 - \varepsilon \right) = n_e / (1 - \varepsilon).
\]

(4)

Simplifying equation (4) for \( \varepsilon \), and taking the square root of both sides of the expression, gives \( \sqrt{1 - (n_e/n_e)} = \sqrt{\varepsilon} \). Again, \( \varepsilon = \varepsilon_0 \varepsilon \), where \( \varepsilon_0 \approx 1/4 \pi \) is the permittivity of free space and \( \varepsilon \) is the dielectric constant of the material. So above-mentioned relationship can be simplified as

\[
\sqrt{1 - (n_e/n_e)} = \sqrt{\varepsilon_0 \varepsilon} = \pm R,
\]

(5)

where \( R \) is a constant. The RI of the plasmon \footnote{\textit{MALLICK}} can be defined as \( n = \sqrt{1 - (n_e/n_e)} \), since for x-rays \( n_e >> n_e, n = 1 - (n_e/2 n_e) \), hence from equation (5) the RI can be written as

\[
n = 1 - (n_e/2 n_e) = \pm R.
\]

(6)

It is clear from the above that, if \( n_e << R, \) RI becomes negative. Also, \( n \) is directly proportional to \( R = \sqrt{\varepsilon_0 \varepsilon} \) or \( \sqrt{\varepsilon} \). The numerical factor \( R \) increases with a higher value of \( \varepsilon \). Again, for x-ray of wavelength \( \lambda \), the plasmon critical density \footnote{\textit{MALLICK}} can be defined as \( n_e = \pi / (r_0 \lambda^2) \), where \( r_0 \) is the classical electron radius and the relation show that if the wavelength of x-ray increases (low energy), \( n_e \) will decrease, hence RI of the material moves towards negative. So, for the negative refractive index (NRI), i.e. \( n = -R \), material behaves as a metamaterial. x-ray reflected from the standing wave pattern receding in the solid-state plasma media (virtual metamaterial), generated because of Compton effect, produces waves of increased frequency. For a wave (x-ray) traveling in normal dispersive media (stationary frame of reference) incident on a receding grating, the receding grating velocity or group velocity (\( v_{\text{group}} \)) and the phase velocity (\( v_{\text{phase}} \)) of the incident wave (x-ray) are parallel therefore, the incident field in the frame of the receding grating oscillates with a relatively low frequency as expected for conventional Doppler effect shown in Figure 1(b). In the anomalously dispersive medium (solid-state plasmon), the \( v_{\text{phase}} \) of the incident wave and \( v_{\text{group}} \) are anti-parallel. In this case the incident field in the frame of receding grating (in excited electron/plasma medium) oscillates with a relatively high frequency as expected for the inverse Doppler effect. Again RI is given as \( n = c/v_{\text{phase}} \), which shows that for NRI material (solid-state plasma) the phase velocity becomes negative and \( v_{\text{group}} = c^2 / (\pm v_{\text{phase}}) \), so the receding velocity. If \( v' \) is the velocity of standing wave (\( v' << c \)) formed due to recoil (ejected) electron (Compton effect) and plasmon in the fixed coordinate system, then the receding velocity in the moving coordinate system is \( v'/2 \). The de Broglie waves representing the plasmon thus form a Bragg grating space \( d' = h/(m'v') \), where \( d' < d \). Similarly, the momentum of the electron then changes from \( -m'v' / 2 \) to \( +m'v' / 2 \) as expressed in the moving system. As per equations (1) and (2), one can have

\[
(2h/\lambda) \sin \theta = m'v'.
\]

(7)

According to general theory of relativity and de Broglie hypothesis, energy of exited electrons can be expressed
as \( E = E_0/\sqrt{1 - (v'/c)^2} \), so
\[
\frac{v'}{c} = \sqrt{1 - (E_0/E)^2},
\]
(8)

where \( E_0 (= m_0c^2) \) is the rest-mass energy of the electron, and \( E = m'c^2 = E_0 + \Delta E \), \( \Delta E \) is the amount of energy gained by the electron in collision process. The mass in terms of energy can be written as
\[
m' = m_0(E/E_0).
\]
(9)

Similarly, according to the Doppler’s principle, the new modified wavelength of the radiation can be defined as \( \lambda'' = \lambda (1 - (v'/c) \sin \theta) \). Further simplifying the above relation for solid-state plasmon system by substituting the value of \( v' \) from equation (7) and \( m' \) from equation (9), the change (decrease) in wavelength can be written as
\[
\Delta \lambda_N = \left[ \frac{2\hbar}{m_0 \frac{E}{E_0} c} \right] \sin^2 \theta = \left( \frac{\hbar}{m_0 c} \right) \left( \frac{E_0}{E} \right) (1 - \cos 2\theta)
\]
(10)

The energy enhancement in this new effect is of the same order as the amount of energy absorbed in Compton process.

3. Theory

In a typical x-ray Compton scattering experiment, a beam of monochromatic radiation with energy \( \omega_1 \) and momentum \( k_1 \) is incident on a target consisting of a set of scatterers. The radiation is scattered through an angle \( 2\theta \) with respect to the incident beam direction. The scattered radiation of energy \( \omega_2 \) and momentum \( k_2 \) (\( \hbar = 1 \)) is analysed. The various steps of interaction mechanism are discussed below.

3.1. Electron at rest

If the electron of the scatterer is supposed to be at rest and free, then from the energy momentum conservation laws we have
\[
\hbar \omega_1 = \hbar \omega_2 + \left( \hbar^2 k^2 / 2m_0 \right),
\]
(11)

where
\[
k = k_1 - k_2.
\]
(12)

Here \( k \) is the scattering vector, and \( k_i \) (\( i = 1, 2 \)) are the wave vectors having magnitude \( |k_i| = 2\pi/\lambda_i \). The energy transferred to the system in this process is
\[
\Delta \hbar \omega = \hbar \omega_1 - \hbar \omega_2 = \left( \hbar^2 k^2 / 2m_0 \right).
\]
(13)

In terms of the scattering angle \( 2\theta \),
\[
k^2 = (k_1 - k_2)^2 = k_1^2 + k_2^2 - 2k_1 k_2 \cos 2\theta.
\]
(14)

Typically, the energy of the x-ray photon is usually very high compared to its momentum. So, to a first approximation \( |k_1|^2 \approx |k_2|^2 \), so
\[
k^2 = 2k_1^2 - 2k_1^2 \cos 2\theta = 2k_1^2 (1 - \cos 2\theta).
\]
(15)
Since, $\omega_1 = k_1 c$ and $\omega_2 = k_2 c$, equation (13) may be written as

$$\Delta h \omega = \left( \frac{h^2 \omega_1 \omega_2}{m_0 c^2} \right) \left( 1 - \cos 2\theta \right)$$

(16)

This gives the final energy of the Compton scattered x-ray photon as

$$h \omega_2 = \frac{h \omega_1}{\left[ 1 + \gamma \left( 1 - \cos 2\theta \right) \right]}$$

(17)

where $\gamma = \frac{h \omega_1}{m_0 c^2}$ is the ratio of the incident photon energy with respect to rest mass energy of electron.

In other words, the change in wavelength of the x-ray photon is the same as defined in earlier expression (3).

### 3.2. Electron in motion

For an electron in motion, equation (11) is slightly modified to

$$h \omega_1 + \left( \frac{p_1^2}{2m_0} \right) = h \omega_2 + \left( \frac{p_2^2}{2m_0} \right)$$

(18)

and

$$hk_1 + p_1 = hk_2 + p_2;$$

(19)

or,

$$p_2 = p_1 + hk;$$

(20)

where $p_1$ and $p_2$ are the initial and final momentum of the electron, respectively.

Using equations (18) and (20), the amount of energy transferred to electrons may be written as

$$\Delta h \omega = h \omega_1 - h \omega_2 = \left( \frac{p_2^2}{2m_0} \right) - \left( \frac{p_1^2}{2m_0} \right)$$

$$= \left( \frac{(p_1 + hk)^2}{2m_0} \right) - \left( \frac{p_1^2}{2m_0} \right);$$

so,

$$\Delta h \omega = \left( \frac{h^2 k^2}{2m_0} \right) + (hk \cdot p_1/m_0).$$

(21)

Here, $k$ is the scattering vector (Figure 2(a)); and for a fixed $k$, the energy resolution is linearly related to the momentum resolution. It is conventionally chosen as the $z$-axis of a Cartesian coordinate system. In addition to equation (16), equation (21) now contains an extra term which is linearly dependent on one component $p_z$ of the electrons ground state momentum and the Doppler shift associated with electron in motion. The Compton profile (CP) is centered around $k^2/2m_0$ with a width $k \cdot p_1/m_0$. 

Figure 2. Schematic diagram of. (a) Compton process showing momentum conservation, where \( p_1 \) and \( p_2 \) are the initial and final momenta of the electron, \( k_1 \) and \( k_2 \) of the x-ray photon. \( E_1, \) and \( E_2, \) are the initial and final energy of the electron, \( \omega_1 \) and \( \omega_2 \) of the x-ray photon. The \( k \) is the scattering vector recedes from the collision centre; (b) new scattering process showing momentum conservation where \( p_3 \) and \( p_1 \) are the initial and final momenta of the excited electron (plasmon) due to Compton effect, \( k_1 \) and \( k_3 \) of the x-ray photon. \( E_3, \) and \( E_1, \) are the initial and final energy of the plasmon, \( \omega_1 \) and \( \omega_3 \) of the x-ray photon. The \( \vec{k}_p \) is the scattering vector approaching to the collision centre.

Hence, we have:

\[
\Delta \hbar \omega = (\hbar \omega_1 - \hbar \omega_2) + (\hbar k p_1 / m_0)
\]

or,

\[
\hbar \omega_2 = \hbar \omega_1 - \Delta \hbar \omega + (\hbar k p_1 / m_0)
\]

or,

\[
\hbar \omega_2 = \hbar \omega_1 - (\hbar^2 \omega_1 \omega_2 / m_0 c^2) (1 - \cos 2\theta) + (\hbar k p_1 / m_0)
\]

or,

\[
\hbar \omega_2 \left(1 + \left(\hbar \omega_1 / m_0 c^2\right) (1 - \cos 2\theta)\right) = \hbar \omega_1 + (\hbar k p_1 / m_0). \tag{22}
\]

Again, the term \( \frac{\hbar}{m_0} k p_1 \) in equation (22) can be simplified using equation (15) as

\[
\frac{\hbar}{m_0} k p_1 = \frac{\hbar}{m_0} \sqrt{2 k_1^2 (1 - \cos 2\theta)} \cdot m_0 v,
\]

\[
\frac{\hbar}{m_0} k p_1 = \frac{\hbar}{m_0} \left(2 \left(\frac{\omega_1}{c}\right) \frac{\sqrt{\sin^2 \theta}}{\sin \theta}\right) \cdot m_0 v = 2 \hbar \omega_1 \left(\frac{v}{c}\right) \sqrt{\sin^2 \theta}. \tag{23}
\]

Finally, from equation (22) and (23)

\[
\hbar \omega_2 = \frac{\hbar \omega_1}{[1 + \gamma (1 - \cos 2\theta)]} + \frac{2 \hbar \omega_1 \left(\frac{v}{c}\right) \sqrt{\sin^2 \theta}}{[1 + \gamma (1 - \cos 2\theta)]}. \tag{24}
\]
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The second term of the above equation (24) is the width of the Compton band in terms of energy. Here, expressing equation (24) in terms of wavelength shift, we have

\[ \delta \lambda_c = \left( \frac{2h}{m_0c} \right) \sin^2 \theta + 2 \left( \lambda \lambda' \right) \frac{\hat{p}_s}{m_0c} \sin \theta. \] (25)

3.3. Electron in oscillating state

In Compton effect, a photon of energy \( \hbar \omega_1 \), scattered through an angle \( 2\theta \) from materials consisting of set of rest and free electrons having initial momentum \( p_1 \), becomes a scattered photon of reduced energy \( \hbar \omega_2 \). These rest and free electrons absorb the amount of energy lost by the photon scattered with a momentum \( p_2 \). Hence, there is a vacancy in the atomic orbit. However, the number of positive charges in the centre remains constant. Then the electron density fluctuation takes place. Hence the excited oscillatory motion of fluctuating bound electrons possesses a new momentum \( p_3 \). These excited electrons, after transforming energy to another incident x-ray photon, attain a relaxed state of momentum \( p_1' \), which is nearly the same as the initial momentum \( p_1 \). X-ray photon scattered from the above oscillating electrons (solid-state plasmon) shows a new type of incoherent scattering of enhanced energy \( \hbar \omega_3 \). From energy momentum conservation laws we have

\[ \hbar \omega_1 + \left( \frac{p_3^2}{2m_0} \right) = \hbar \omega_3 + \left( \frac{p_1'^2}{2m_0} \right) \] (26)

and

\[ \hbar k_1 + p_3 = \hbar k_3 + p_1' \] (27)

or,

\[ p_3 = \hbar k_3 - \hbar k_1 + p_1; [p_1' = p_1] \] (28)

where \( p_3 \) and \( p_1 \) are the initial and final momentum of excited plasmon, respectively, \( k_3 \) is the final momentum of new scattered photon, and \( k_p = k_3 - k_1 \) is the scattering vector shown in Figure 2(b). The amount of energy transferred to x-ray photon from excited electron (plasmon) may be written as

\[ \Delta \hbar \omega|_N = \hbar \omega_3 - \hbar \omega_1 = \left( \frac{p_3^2}{2m_0} \right) - \left( \frac{p_1'^2}{2m_0} \right) \]

so,

\[ \Delta \hbar \omega|_N = \left( \hbar^2 k_p^2/2m_0 \right) + \left( \hbar k_p p_1/m_0 \right), \]

or,

\[ \Delta \hbar \omega|_N = \left( \frac{\hbar^2 k^2}{2m_0} \right) + \left( \hbar k_p p_1/m_0 \right), \] (29)

which is similar to equation (21). Now, the equation (29) contains an extra term, which is also linearly dependent on the electrons ground state momentum and the inverse Doppler shift associated with electron in plasmon excitation. Hence, the new profile of the scattered photon is centred on \( k_p^2/2m_0 \) with a width \( k_p p_1/m_0 \).

As it is difficult to detect the scattered electron experimentally, one can only record the energy distribution of the Compton scattered x-ray photons and then infer the momentum distribution of the electron. In order to extract the information regarding the momentum of the scattering electron, let us define

\[ q = k' p / |k|, \] (30)
which is the projection of the momentum $p$ onto the scattering vector $k$. From equation (22), one can get after slight modification

$$(hk.p_1/m_0) = -\hbar \omega_1 + \hbar \omega_2 \left(1 + \left(\hbar \omega_1/m_0c^2\right)(1 - \cos 2\theta)\right)$$

so,

$$p_1 = \left(m_0/h\right) \left\{ -\hbar \omega_1 + \hbar \omega_2 \left(1 + \left(\hbar \omega_1/m_0c^2\right)(1 - \cos 2\theta)\right) \right\}.$$  \hspace{1cm} (31)

Since $q \approx p_1$, so

$$q = \frac{\left(m_0/h\right) \left\{ -\hbar \omega_1 + \hbar \omega_2 \left(1 + \left(\hbar \omega_1/m_0c^2\right)(1 - \cos 2\theta)\right) \right\}}{\sqrt{k_1^2 + k_2^2 - 2k_1k_2 \cos 2\theta}}$$

$$= \frac{\left(m_0c\right) \left\{ -\hbar \omega_1 + \hbar \omega_2 + \left(\hbar^2 \omega_1\omega_2/m_0c^2\right)(1 - \cos 2\theta)\right\}}{\sqrt{\hbar^2 \omega_1^2 + \hbar^2 \omega_2^2 - 2\hbar^2 \omega_1 \omega_2 \cos 2\theta}}.$$  \hspace{1cm} (32)

Simplifying equation (32), it gives

$$q = \frac{(-137) \left\{ \hbar \omega_1 - \hbar \omega_2 - \left(\hbar^2 \omega_1\omega_2/m_0c^2\right)(1 - \cos 2\theta)\right\}}{\sqrt{\hbar^2 \omega_1^2 + \hbar^2 \omega_2^2 - 2\hbar^2 \omega_1 \omega_2 \cos 2\theta}}.$$  \hspace{1cm} (33)

where $m_0c = 137 = 1/\alpha$ and the $\alpha$ is the fine structure constant. Again $m_0c\alpha = h/a_0 = 1$ atomic unit of momentum ($= 1.99275 \times 10^{-19} \text{ g} \cdot \text{cm/s}$). In addition, 1 a.u. of energy is equal to 27.2 eV. For convenience, the electron momentum can be expressed in energy unit by multiplying it with velocity of light ‘$c$’. So, 1 atomic unit of momentum (in energy unit) $= 27.2 \times 137.036 \text{ eV} = 3.727 \text{ keV}$.

Thus, with the help of this equation (33), the photon spectrum can be transformed to an electron momentum spectrum. The negative sign implies that for positive $q$ values the energy shift is lower. If one assumes $k$ to be along z-direction, then $q = p_z$, so the CP $J(q)$ becomes $J(p_z)$.

Simplifying equation (29) as per equation (13), similar to the case of electron in motion, gives

$$\Delta \hbar \omega|_N = (\hbar \omega_3 - \hbar \omega_1 + (hk_p p_1/m_0)$$

or,

$$\hbar \omega_3 = \Delta \hbar \omega|_N + \hbar \omega_1 - (hk_p p_1/m_0).$$  \hspace{1cm} (34)

Modifying equation (16) for this scattering gives

$$\Delta \hbar \omega|_N = \left(\hbar^2 \omega_1 \omega_3/m_0c^2\right)(1 - \cos 2\theta').$$  \hspace{1cm} (35)

Simple algebra using equation (34) and (35) leads to the following result:

$$\hbar \omega_3 = \left(\hbar^2 \omega_1 \omega_3/m_0c^2\right)(1 - \cos 2\theta') + \hbar \omega_1 - (hk_p p_1/m_0)$$  \hspace{1cm} (36)

Finally, simplifying equation (37), energy of the scattered photon becomes

$$\hbar \omega_3 = \frac{\hbar \omega_1}{\left[1 - \gamma \left(1 - \cos 2\theta'\right)\right]} - \frac{k_p p_1}{\left[1 - \gamma \left(1 - \cos 2\theta'\right)\right]}.$$  \hspace{1cm} (37)
Simplifying the value of $k_p$, using vector diagram shown in Figure 2(b) and applying the first approximation $|k_1|^2 \approx |k_3|^2$ as in equation (15), one can have

$$k_p = \sqrt{(k_3 - k_1)^2} = \sqrt{k_3^2 + k_1^2 - 2k_1k_3 \cos \theta'}$$

$$= \sqrt{2k_1^2 (1 - \cos \theta')} = 2 \left( \frac{\omega_1}{c} \right) \sqrt{\sin^2 \theta'}.$$  \hspace{1cm} (38)

Hence, the term $\frac{\hbar}{m_0} k_p p_1$ in equation (37), as per equation (28), is actually $\frac{\hbar}{m_0} k_p p_1'$ and can be simplified to

$$\frac{\hbar}{m_0} k_p p_1' = \frac{\hbar}{m_0} \left( 2 \left( \frac{\omega_1}{c} \right) \sqrt{\sin^2 \theta'} \right) \cdot m_0 v' = 2 \hbar \omega_1 \left( \frac{\omega_1}{c} \right) \sqrt{\sin^2 \theta'}. \hspace{1cm} (39)$$

Finally, from Equation 37, energy of the newly scattered x-ray photon can be written as

$$\hbar \omega_3 = \frac{\hbar \omega_1}{\left[ 1 - \gamma (1 - \cos 2\theta') \right]} - \left[ \frac{2 \hbar \omega_1 \left( \frac{\omega_1}{c} \right) \sqrt{\sin^2 \theta'}}{\left[ 1 - \gamma (1 - \cos 2\theta') \right]} \right]. \hspace{1cm} (40)$$

This equation (40) is valid for all angles when $\gamma << 1$, i.e., non-relativistic photon ($< 15$ keV). In this energy range the relativistic effect can be neglected. According to the equation (40), the energy gain by the x-ray photon in this process is of the same order as the amount of energy absorbed in Compton process.

Let us consider $q'$, the plasmons initial state momentum and the new shift associated with the electron oscillation, which may be given as

$$q' = k_p \cdot p / |k_p|.$$  \hspace{1cm} (41)

Hence, $q'$ may be further simplified as,

$$q' = (m_0/\hbar k_p) \left( \left[ \hbar \omega_1 - \hbar \omega_3 + \left( \hbar^2 \omega_1 \omega_3 / m_0 c^2 \right) (1 - \cos 2\theta') \right] \right)$$

$$q' = \frac{(m_0/\hbar) \left( \left[ \hbar \omega_1 - \hbar \omega_3 + \left( \hbar^2 \omega_1 \omega_3 / m_0 c^2 \right) (1 - \cos 2\theta') \right] \right)}{\sqrt{k_1^2 + k_3^2 - 2k_1k_3 \cos \theta'}}$$

$$= \frac{(m_0/\hbar) \left( \left[ \hbar \omega_1 - \hbar \omega_3 + \left( \hbar^2 \omega_1 \omega_3 / m_0 c^2 \right) (1 - \cos 2\theta') \right] \right)}{\sqrt{\hbar^2 \omega_1^2 + \hbar^2 \omega_3^2 - 2\hbar^2 \omega_1 \omega_3 \cos 2\theta'}. \hspace{1cm} (42)$$

Expression (42) gives

$$q' = \frac{(-137) \left( \left[ \hbar \omega_3 - \hbar \omega_1 - \left( \hbar^2 \omega_1 \omega_3 / m_0 c^2 \right) (1 - \cos 2\theta') \right] \right)}{\sqrt{\hbar^2 \omega_1^2 + \hbar^2 \omega_3^2 - 2\hbar^2 \omega_1 \omega_3 \cos 2\theta'}. \hspace{1cm} (43)$$

Thus, with the help of this equation, the photon spectrum can be transferred to an electron momentum spectrum. Thus, $q'$ value will provide vital information to study the new scattering profile, i.e., $J(q')$.

The physical origin of the broadening of the modified line developed by Jauncey [52, 53] and DuMond [54, 55] is known as Compton profile. In that paper, Jauncey pointed out that the interaction between the x-ray photon and the electron in motion gives rise to a second term in the Compton’s expression (3), which is dependent on the components of electron’s ground state momentum along the scattering vector. The Compton profile (CP), i.e., $J(q)$ is centered around $k^2/2m_0$ with a width $k \cdot p_1/m_0$, where $k = k_1 - k_2$ is the scattering
3.4. Intermediate state transition probability

In quantum electrodynamics (QED), a quantized electromagnetic field and free electron interactions involve an initial (ground) state, an intermediate (ionization) state and a final (continuous) state. Momentum and energy are conserved between the initial state and the final state, but in the intermediate state, the theory requires only momentum conservation and not energy conservation. In quantum theory, an external field (if it varies sufficient rapidly) can cause transition from a state of positive energy to state of negative energy [25].

In atomic physics, the ionization level is often assigned the zero energy, and the bound states thus all have negative energies [56]. Hence, the continuum state is assigned positive energy.

As our interest is on scattering of low energy (<15 keV) x-ray photon, we shall confine ourselves to the non-relativistic (NR) case and its correction to Compton effect. According to the non-relativistic interaction (in Coulomb gauge) between an electron and the radiation field, the Hamiltonian [25, 57] is given by

\[ H_{\text{int}} = -\frac{e}{m_0 c^2} (pA) + \frac{e^2}{2m_0 c^2} A^2 = H_1 + H_2, \] (44)

where, \( A \) is the vector potential of x-ray field and \( p \) is the momentum operator for the electron.

In case of transition from bound state (or ground state) to continuous state (or final state), i.e., \((E_0, k_1) \rightarrow (E, k_3)\), as shown in Figure 3, the perturbation term can be defined as

\[ H_1 = -e \sum_k \frac{\alpha_i e_{k_3}}{\sqrt{2} k_1} \left( a_{k_3} e^{ik_3x} + a^\dagger_{k_3} e^{-ik_3x} \right), \quad \left[ a_k = a^{-1} \right]. \] (45)

Here, \( H_1 \) is a first-order term and \( \alpha_i \) is the component of the matrix vector. It can only cause transitions involving two x-ray quanta through the virtual states which differ from the initial and final states by having only one x-ray quantum emitted or absorbed. The free electron wave function for negative energy state, \( \psi = u_i(-P_\mu) e^{-ipx+iEt} \), where \( u_i \) is a spinor function, \( i \) is the spin indices and \( P_\mu \) is a four vector. The \( H_2 \) in equation (44) can be given as

\[ H_2 = \frac{2\pi e^2 \hbar c}{mc^2 \sqrt{k_1 k_3}} \int \psi^*_n e^{i(k_1-k_3)x} \cdot \psi_{n_0} (e_{k_1} \cdot e_{k_3}), \]

\[ = \frac{2\pi e^2 \hbar^2 c^2}{mc^2 \sqrt{k_1 k_3}} e^{i(k_1-k_3)x} \delta_{n_0 n} (e_{k_1} \cdot e_{k_3}), \] (46)
where $\delta_{n_0,n}$ is the delta function, $e_{k_1}, e_{k_3}$ denote unit vectors in the direction of polarization of the two quanta $k_1, k_3$ and the $\mathbf{x}$ denotes a vector specifying the position of the atom.

Denoting the Dirac’s amplitudes of the electron with the momenta $p_0, p, p', p''$ by $u_0, u, u', u''$, respectively, and the $\alpha_i$ in the direction of polarization of the two x-ray quanta $k_1$ and $k_3$ simply by $\alpha_1$ and $\alpha_3$, respectively, the matrix $M$ occurring in the transition probability ($F \rightarrow O$) is formulated as

$$
M = \sum_{n'} \left( \frac{H_{0I}H_{1F}}{E_I - E_O} + \frac{H_{0II}H_{1IF}}{E_{II} - E_O} \right) + \sum_{n''} \left( \frac{u'^* \alpha_3 u'}{E_I - E_O} + \frac{u''^* \alpha_1 u_0}{E_{II} - E_O} \right),
$$

(47)
where the summations are over the four intermediate states including both signs of the energy (±E) and both sign of the spin (↑↓). \( E_i \) is the energy of initial state and \( E'_a, E''_a \) are the energies of the two types of intermediate state. \( E_O, E_I, \) and \( E_{II} \) denote the total energies in the initial and intermediate states. For calculation of the transition probability from the final state \( F(k_3, p_3 \neq 0) \) to the initial state \( O(k_1, p_1 = 0) \), assuming that the process can happen only by passing through an intermediate state which can differ by one quantum (ℏω) only from O or F, the respective Hamiltonian [25], can be expressed as

\[
H_{IF} = (n' | H_1 | f) = -e \sqrt{\frac{2\pi \hbar^2 c^2}{k_3}} (u'^* \alpha_3 u),
\]

\[
H_{OI} = (i | H_1 | n') = -e \sqrt{\frac{2\pi \hbar^2 c^2}{k_1}} (u_1 \alpha_1 u'),
\]

\[
H_{IF} = (n'' | H_1 | f) = -e \sqrt{\frac{2\pi \hbar^2 c^2}{k_3}} (u''^* \alpha_1 u),
\]

\[
H_{OI} = (i | H_1 | n'') = -e \sqrt{\frac{2\pi \hbar^2 c^2}{k_3}} (u_1 \alpha_3 u'').
\]

Only the momentum and not the energy is conserved in these intermediate or virtual states. Hence, the energy difference can be formulated as

\[
E_I - E_O = E' - (m_0 c^2 + k_1)
\]

\[
E_{II} - E_O = (E'' + k_1 + k_3) - (m_0 c^2 + k_1)
= (E'' + k_3) - m_0 c^2.
\]

The transition probability per unit time for the new scattering process can be defined as

\[
w = \frac{2\pi}{\hbar} |M|^2 \rho_F,
\]

where \( \rho_F \) denotes the number of final states per energy interval \( dE_F \). Since the final energy is given as a function of \( k_3 \) and \( \theta' \), one can have

\[
E_F = k_3 + \sqrt{k_p^2 + (m_0 c^2)^2}
\]

\[
k_p^2 = k_1^2 + k_3^2 - 2k_1 k_3 \cos 2\theta'.
\]

Thus, \( \left( \frac{dk}{dE_F} \right)_\theta = \frac{E k_3}{k_1 m_0 c^2} \), where \( E \) is the electron energy in the final state and

\[
\rho_F = \rho_k \left( \frac{dk}{dE_F} \right)_\theta
\]

\[
[\rho_F \cdot dE_F = \rho_k \cdot dk]
\]

\[
\rho_F = \frac{d\Omega k_3^3}{(2\pi \hbar c)^3} \frac{E k_3}{k_1 \cdot m_0 c^2}
\]

where \( d\Omega = 2\pi \sin \theta \, d\theta \), is the element of solid angle for the scattered quanta.
Applying equation (49) and (50) in the equation (47), one can have

\[ M = \sum_{n'} \left( u^\ast \alpha u \right) \left( u'^\ast \alpha u_0 \right) \left( E' - (m_0c^2 + k_3) \right) + \sum_{n''} \left( u^\ast \alpha u'' \right) \left( u'^\ast \alpha u_0 \right) \left( E'' - (m_0c^2 - k_3) \right) \]

\[ = M_1 + M_2 \]  

(55)

As defined by Heitler [25], simplifying the differential cross section for this scattering of the photon into the momentum state \( k_3 \), we have

\[ d\sigma = \frac{e^4 E k_3^2}{k_1^2 \cdot m_0c^2} |M|^2 \ d\Omega. \]

(56)

On rearranging equation (56), it becomes

\[ \frac{d\sigma}{d\Omega} = \left( \frac{k_3^2}{k_1^2} \right) \left( \frac{E}{m_0c^2} \right) e^4 |M|^2. \]

(57)

This result is valid for a given polarization of both quanta and a given spin direction of the electron in the initial and final states. The summations in equation (55) are over all spin directions and both signs of the energy for the intermediate states. Hence, the energy denominators of \( M \) are different for the positive energy and negative energy state.

Further simplifying, the above equation (57), one can have

\[ \frac{d\sigma}{d\Omega} = \left( \frac{e^2}{m_0c^2} \right)^2 \left( k_3^2 / k_1^2 \right) \left( E / m_0c^2 \right) |M|^2, \]

(58)

where \( \frac{e^2}{m_0c^2} \) (\( = r_0 \)) has the dimension of length, the so-called “classical electron radius” and is equal to \( 2.82 \times 10^{-13} \) cm. Hence,

\[ \frac{d\sigma}{d\Omega} = (r_0)^2 \left( k_3^2 / k_1^2 \right) \left( E / m_0c^2 \right) |M|^2 \]

(59)

or,

\[ \frac{d\sigma}{d\Omega} = (\sigma_T) \left( k_3^2 / k_1^2 \right) \left( \frac{3 E m_0c^2}{8\pi} \right) |M|^2 \]

(60)

where \( \sigma_T \) (\( = 6.65 \times 10^{-25} \) cm\(^2\)/electron) is known as the Thompson scattering cross section. The deduction of QED cross section can be done with the evaluation of the matrix \( M \) in equation (60) (see Appendix-A for derivation). The derivation of the cross section, which ends up with equation (58), is based solely on the \( \mathbf{p} \cdot \mathbf{A} \) term of the interaction Hamiltonian. As mentioned in Ohmura and Matsudaira [58], in the x-ray plasmon scattering the term \( \mathbf{p} \cdot \mathbf{A} \) is negligible in Compton cross section for all possible practical scattering angles [59]. Hence, the contribution of the \( \mathbf{A}^2 \) term of the interacting Hamiltonian to the x-ray Compton cross section is the prime interest here. Therefore, the scattering cross section (based solely on the \( \mathbf{A}^2 \) term) was derived applying statistical approach described below.
3.5. Scattering cross section

In the statistical model of the atom, incoherent scattering cross section of x-rays by a system of interacting particles is expressible in terms of density distribution functions for the system \([60, 61]\) as

\[
\sigma(\mathbf{k}) = \sigma_T \int P(\mathbf{k}, r) n(r) \, dr,
\]

where \(P(k, r)\) is the local correlation function, and \(n(r)\) is the electron density function.

However, the maximum information about the many-particle system is contained in the quantity \(P(k, \omega)\), which is the Fourier transformation in space and time of the time-dependent pair-distribution function for the system \([60–63]\) and is also known as spectral function. The spectral function \(P(k, \omega)\) is directly measured in an inelastic-scattering experiment. Applying the Born approximation, one can find the angular and energy distribution of scattered photon as

\[
\frac{d^2 \sigma}{d\Omega \, d\omega} = \frac{m_0^2 \, p_3}{8 \pi^3 \, p_2} \, V_k^2 \, P(k, \omega)
\]

for the particle (electron) of mass \(m_0\), initial momentum \(p_2\) scattered to a final momentum \(p_3\), with energy transfer between \(\omega\) and \(\omega + d\omega\), and scattering angle specified by \(d\Omega\). The energy transfer \(\Delta \hbar \omega|_N\) is related to the momentum transfer and scattering angle as given in expression (29). In the case of collective mode, the Coulomb interaction factor \(V_k\) \([62]\) is simplified as

\[V_k = 4\pi \, e^2/k^2_p.\]

However, the static Coulomb interaction generated due to the scalar field (static field) \(\phi (r, t)\), a well-defined function of the particle coordinates at the same time \([25]\).

Again, this \(P(k, \omega)\) is related to the structure factor \(P(k)[62]\) by

\[
\int_{-\infty}^{\infty} P(k, \omega) \, d\omega = P(k) \, n_e
\]

where, \(P(k) = \langle \psi_o | \rho_k^+ \rho_k | \psi_o \rangle / n_e\), and the \(P(k)\) is directly measured in a scattering experiment in which one determines the differential cross section. Then the differential cross section is determined by integrating over all energy transfers \([62]\):

\[
\frac{d\sigma}{d\vartheta} = \int_0^{\infty} \frac{d^2 \sigma}{d\theta \, d\omega} \, d\omega = \frac{m_0^2 \, p_3}{8 \pi^3 \, p_1} \, V_k^2 \, P(k) \, n_e.
\]

For the evaluation of the incoherent form factor by applying non-interacting Fermi gas models of the atom such as Thomas-Fermi (TF) and Thomas-Fermi-Dirac (TFD) fails to explain in this system. The deficiencies of the above models can be removed by introducing the correlations brought about by the electrostatic interaction between electrons, i.e., considering the interacting Fermi gas \([61]\). As described, the interacting Fermi gas model deals with relation between the pair distribution function and the dielectric constant of the uniform gas \([61, 64]\).

In the interacting Fermi gas model, the correlation term \(P(k, r)\) used in the above equation (61) can be taken as \(P(k)\) (for brevity by omitting the argument \(r\)) and can be expressed in the random-phase approximation.
(RPA) as a function of dielectric constant \( \varepsilon(k, \omega) \) as

\[
P(k) = \frac{\hbar k_p^2}{4\pi^2 n_e \varepsilon^2} \int_0^\infty \frac{\varepsilon_2(k, \omega)}{\varepsilon(k, \omega)} d\omega
\] (66)

where, \( \varepsilon(k, \omega) = \varepsilon_1(k, \omega) + i \varepsilon_2(k, \omega) \).

After a bit of algebraic simplification, one can have the \( P(k) \) as the same as given in earlier expression (64).

The various physical phenomena existing within the concept of incoherent x-ray scattering can be classified in three meaningful categories according to the associated energy transfer \( \Delta \hbar \omega \) (expression (21)) and momentum transfer \( k \) (expression (15)) in relation to the characteristic energies or structural dimensions. The above three distinct regimes are: the Compton scattering regime \( (\Delta \hbar \omega > > E_B, \ k \ r_{nl} > > 1) \), i.e., the energy (momentum) transfer is large compared to the binding energy \( E_B \) (inverse of the orbital radius \( r_{nl} \)) of the target electron; the characteristics excitation (Raman scattering) regime \( (\Delta \hbar \omega \approx E_B, \ k \ r_{nl} \approx 1) \), i.e., the energy (momentum) transfer is comparable to the \( E_B \) (inverse of the \( r_{nl} \) or inter atomic distance) of the target system; and the collective scattering regime \( (\Delta \hbar \omega < < 1 \text{ keV}, \ k \ r_{nl} < < 1) \), i.e., the energy (momentum) transfer is very small \( (< 1 \text{ keV}) \) compared to \( E_B \) (inverse of inter atomic distance) of the target material [65]. The excitation may be either of local or collective type. In a uniform gas, for small values of the wave number \( k_p \), there are two kinds of excitation contributions to \( P(k) \); one is the particle-hole pair excitations and the other one is the collective excitations [61, 62]. For electron gas, the collective mode is the plasmon. A quantized plasmon oscillation correspond to oscillations in the particle density. The collective contribution to \( P(k) \) in the small \( k_p \) region is, to an accuracy \( k_p^4 / k_{TF}^4 \),

\[
P_{\text{col}}(k) = \frac{\hbar^2 k_p^2}{2m \omega_k}
\] (67)

where \( \omega_k \) is the oscillation frequency of the collective mode with the wave number \( k_p \) and \( k_{TF} \) is the Thomas-Fermi screening wave number, \( k_{TF}^2 = (4/\pi)(k_F/a_0) \), and \( a_0 \) is the Bohr radius [62].

The dielectric function \( \varepsilon(\omega, k) \) of the electron gas is strongly dependent on the frequency and wavevector. A number of theories or models related to \( \varepsilon(\omega, k) \) has been given [63]. Due of the complexity of the many body problem, knowledge of the exact dielectric function is still lacking. However, we are interested, here, in RPA type dielectric function. The RPA is also called the Lindhard dielectric function and is a model for a static \( \varepsilon(k) \) or dynamic \( \varepsilon(\omega, k) \) dielectric function [63]. For brevity, we do not exhibit here the frequency dependence (the predicted scattering is highly dependent on critical number density of plasom \( n_c \)).

According to the dispersion relation, the collective frequency \( \omega_k \) of the electromagnetic wave propagated in solid [50] can be simplified as

\[
\omega_k = \left[ \left( \frac{\varepsilon k_p^2}{\varepsilon(\omega, k)} \right) \right]^{1/2} = \left[ \left( \frac{4\pi \varepsilon k_p^2}{\varepsilon} \right) \right]^{1/2}
\] (68)

As it is already mentioned earlier, \( \varepsilon = \varepsilon_0 \varepsilon \), and \( \varepsilon_0 = 1/4\pi \) (see the hypothesis, i.e., section 2). Also, using equation (4),

\[
\omega_k = \left[ \left( \frac{\varepsilon k_p^2}{(n_c - n_e)/n_c} \right) \right]^{1/2}.
\] (69)
Hence, simplifying equation (65) using expressions (63) and (67), one can have

\[
\frac{d\sigma}{d\vartheta} = \frac{m_0^2}{8\pi^3} \frac{p_1}{p_2} \left( \frac{4\pi e^2}{k^2} \right)^2 \frac{h^2 k_p^2}{2m_0 \omega_k} n_e
\]

\[
= \frac{m_0^2}{8\pi^3} \frac{p_1}{p_2} \left( \frac{4\pi e^2}{k^2} \right)^2 \frac{h^2 k_p^2}{2m_0} \left[ \frac{\varepsilon}{4\pi e^2 k_p^2} \right]^\frac{1}{2} n_e \text{[substituting } \omega_k \text{ from (68)]}
\]

\[
= \left( \frac{e^2}{m_0 c^2} \right)^2 \left( \frac{1}{k_p} \right)^3 \left( \frac{(m_0 c)^4}{16\pi^3} \frac{p_1}{p_2} \frac{\hbar^2}{(m_0 c)} \right) \left[ \frac{3}{p_3} \right] \left[ \frac{\pi}{\varepsilon} \right] n_e
\]

\[
= (r_0)^2 \left( \frac{1}{k_p} \right)^3 \left[ \frac{(m_0 c)^3 h^2 (4\pi)^{\frac{3}{2}}}{16\pi^3} \right] \left[ \frac{3}{p_3} \right] \left[ \frac{\pi}{\varepsilon} \right] n_e
\]

\[
= \sigma_T \left( \frac{1}{k_p} \right)^3 \left[ \frac{(137)^3 h^2}{\pi^2} \right] \left[ \frac{3}{p_3} \right] \left[ \frac{\pi}{\varepsilon} \right] n_e.
\]

Hence,

\[
\frac{d\sigma}{d\vartheta} = \sigma_T \left( \frac{1}{k_p} \right)^3 M_c \frac{p_3}{p_2} \left( \frac{\pi}{\varepsilon} \right)^{\frac{1}{2}} n_e,
\]

(72)

where \( M_c \approx 2.756 \times 10^4 \) is a constant quantity, since, \( m_0 c = 137 \) and considering \( h = c = 1 \), as used to study x-ray scattering from electron gas [17, 18]. Since the solid angle \( \Omega(r, \theta') \) is a function of \( r \) and \( \theta' \), the above equation (72) can be written as

\[
\left( \frac{d\sigma}{d\Omega} \right)_N = \sigma_T \left( \frac{1}{k_p} \right)^3 M_c \frac{p_3}{p_2} \left( \frac{\pi}{\varepsilon} \right)^{\frac{1}{2}} n_e
\]

(73)

However, \( (d\sigma/d\Omega)_N \) over this plasmon line is already defined in DuBois and Gilinsky [14].

The total cross section of this new incoherent scattering can be obtained by integrating the equation (73) over the solid angle, \( d\Omega = 2\pi \sin \theta' d\theta' \):

\[
\sigma_N = \int \left( \frac{d\sigma}{d\Omega} \right)_N d\Omega
\]

(74)

or,

\[
\sigma_N = \sigma_T \left( \frac{1}{k_p} \right)^3 M_c \frac{p_3}{p_2} \left( \frac{\pi}{\varepsilon} \right)^{\frac{1}{2}} n_e \int_0^\pi 2\pi \sin \theta' d\theta'.
\]

(75)

Finally, the total scattering cross section of this new scattering is found out to be

\[
\sigma_N = \sigma_T \left( \frac{1}{k_p} \right)^3 M_c \frac{p_3}{p_2} \left( \frac{\pi}{\varepsilon} \right)^{\frac{1}{2}} n_e (4\pi),
\]

(76)

where the scattering vector \( k_p \) has magnitude \( k_p = (4\pi/\lambda'') \sin \theta' \). Hence, the new scattering cross section is found out to be inversely proportional to the third power of momentum transfer, i.e., \( k_p^{-3} \). In addition, this new
scattering cross section is found out to be directly proportional to the $\sqrt{\varepsilon}$ as predicted in the hypothesis. Also the final momentum $p_3$ or the momentum of the relaxed electron after scattering of the photon of enhanced energy is the same as the initial momentum $p_1$, i.e. $p_3 \approx p_1$.

Further simplified, alternative form of the total scattering cross section of this new scattering is found out to be

$$\sigma_N = \sigma_T \left( \frac{1}{k_p} \right)^3 M'_c \frac{p_3}{p_2} \left( \left| \frac{n_e - n_c}{n_c} \right| \right)^{\frac{1}{2}} n_e,$$

(77)

where $M'_c \equiv (4\pi)^{\frac{1}{2}} M_c$ is a constant.

### 3.6. Scattering intensity

The scattered intensity is described by the double differential cross section $\frac{d^2\sigma}{d\Omega d\omega}$, and the inelastic scattering intensity includes both contributions of the coherent and the incoherent parts. Physical concepts behind both the scattering parts and their respective functions are given elsewhere [66, 67]. Theoretical calculation of the intensity of scattering of x-rays by recoiling electrons is defined by Woo [68]. However, for the experimental intensity of inelastic scattering as observed by Paakkari and Suortti [69] for the symmetrical-reflection geometry, i.e., the incident and detected rays making equal angle $\theta$ with the flat specimen surface, the expression is modified because of this new type incoherent scattering to

$$I = I_O \Omega M_O K_{pol} \frac{(d\sigma/d\Omega)_C}{\mu_O + \mu_C} + \frac{(d\sigma/d\Omega)_{TDS}}{2\mu_O} + \frac{(d\sigma/d\Omega)_N}{\mu_O + \mu_N},$$

(78)

where $I$ is the intensity of the inelastic scattering, $I_O$ is the intensity of the primary beam, $\Omega$ is the solid angle subtended by the receiving slit, $M_O$ is the number of atoms per unit volume and $K_{pol}$ is the ratio of the polarization factor of the scattered radiation to that of the monochromatic primary beam. In the present case, this can be written [69] as

$$K_{pol} = \frac{(1 + K' \cos^2 2\theta')}{(1 + K')},$$

(79)

where $K' \equiv I(\pi)/I(\sigma)$ is the polarization ratio of the primary beam.

Again, in the above equation (79), the linear absorption coefficients for the unmodified, Compton-modified and modified by this new incoherent process are denoted by $\mu_O$, $\mu_C$ and $\mu_N$, respectively. Also, the scattering cross sections per atom are: for the Compton process C, $(d\sigma/d\Omega)_C$, for the thermal diffusion scattering $TDS$, $(d\sigma/d\Omega)_{TDS}$, and for the new incoherent scattering process, $(d\sigma/d\Omega)_N$. This new scattering cross section has been derived in the earlier section (3.5) of this paper in equation (74). However, the other two scattering cross sections have already been reported by others elsewhere [69].

### 4. Experimental

X-ray scattering experiments have been carried out using two types of x-ray instruments, i.e., wavelength dispersive x-ray (WDXR) spectrometry [70] and energy dispersive x-ray fluorescence (WDXR and EDXRF) spectrometry [71, 72] techniques for spectroscopic analysis of materials. The details of the WDXR, EDXRF spectrometry techniques are discussed below.
4.1. Wavelength dispersive x-ray spectrometry

A WDXR spectrometer (Philips analytical x-ray instrument, Model No.-PW 3020, Netherlands) employing Bragg-Brentano parafocusing optics with an energy resolution $\Delta E / E = 1 \times 10^{-3}$ was used for the scattering study. The system shows the FWHM of 8 eV at 8 keV x-ray, which corresponds to a momentum resolution of about 0.16 a.u., calculated using the relations given in references [73–75].

A section was examined via the scattering geometry shown in Figure 4(a). Incident line focus came from CuK$_\alpha$ or CoK$_\alpha$ radiation produced by a high-power ceramic tube of focus dimension 12 mm $\times$ 0.4 mm, operated at 40 kV and 40 mA using a 2.0 kW (40 kV and 50 mA) x-ray generator. Radiation was passed through a Be window having 93% transmission, emitting CuK$_\alpha$ x-ray ($1.289 \times 10^{-15}$ J) photons on the order of $1.2 \times 10^{16}$ photons/s ($= \frac{1600 \text{ W} \times 0.93 \times 0.01}{1.289 \times 10^{-15} \text{ J}}$, with only 1% of power converted to CuK$_\alpha$ x-ray, which can be achieved using modern high-power ceramic tube). Monochromatic photons of the order of $10^9$ photon/s can be obtained using a presently available high-power sealed-off tube [75]. The CuK$_\alpha$ excitation from the line focus tube was filtered by a $\beta$-filter, then the x-ray beam was collimated through Soller slit (SS) of 0.04 rad., fixed divergence slit (FDS) of 2$^\circ$ and mask (10 mm) before irradiating the sample. The scattered x-ray beam from the sample was well collimated by passing it through a programmable anti-scattering slit (PASS) of 2$^\circ$ (to reduce air scattering), programmable receiving slit (PRS) of 0.8 mm and Soller slit (SS) of 0.04 rad. before getting it reflected by the Johannson-type curved graphite crystal (002) monochromator of radius 225 mm. The monochromator crystal has an interplaner spacing is 3.383 Å. The graphite monochromator gives an intensity gain of about 70 in comparison with silicon crystals in the same geometry [76]. Since x-ray absorption depends approximately on $Z^4$, while maximum possible diffraction power is proportional to $Z^2$ (mosaic crystal case), where $Z$ is the atomic number, the crystals of the lighter elements are expected to form better monochromators than those of heavier elements [2, 77]. A sophisticated Xe-gas filled proportional counter (PW 3011) having 8 mm $\times$ 26 mm window size and 19% energy resolution was mounted on the arm of the goniometer circle of radius 200 mm. The counter is capable to possess maximum count rate of 750 kcps with a background of 2 cps. Step size chosen for this experiment was 1$^\circ$. In this arrangement, x-rays are reflected from both the specimen and the focusing monochromator, which is known as reflection-reflection mode in double-crystal spectrometry (+ -) [2]. Data have been collected in an absolute-scan mode (scanning 2$\theta$ and keeping sample fixed with respect to the beam direction). Experimental set up was fully computer-controlled. The observed spectra were fitted using X’Pert Graphics software supplied by Philips, Netherlands [78].

4.2. Energy dispersive x-ray spectrometry

Samples were also characterized via Energy Dispersive X-ray Fluorescence (EDXRF) using an Oxford model XTF-5020/W triple-axis EDXRF spectrometer as shown in Figure 4(b). Power supply unit used is the SPELLMAN, USA (50 kV/2.0 mA) air-cool unit. The experiment was performed on powder and crystals using MoK$_\beta$ and PbL$_\alpha$ x-rays as a secondary radiation from a tungsten anode based x-ray tube operated at 40 kV and 1 mA. The crystal was mounted in such a way that scattered radiation was received by the Canberra, USA make Si (Li) detector (Model no. SL30160) set at 90$^\circ$ and 125$^\circ$ with respect to the incident beam. The detector head is placed at a distance of 30 mm from the sample surface. The scattered beam consisting of coherent, incoherent components and fluorescence is directly counted by a 3 mm thick Si(Li) crystal.
The Si(Li) detector having an 8 \( \mu \)m thick beryllium window with a resolution of 180 eV (FWHM) at 5.9 keV x-ray with a momentum resolution about 0.39 a.u at a back scattered geometry, calculated using the relations given in the references [74, 75, 79]. The detector signal was further amplified (shaping time 2 \( \mu s \)) using an ORTEC 572A amplifier mounted in an ORTEC BIN (Model No. 4001C). This amplified signal was fed into an automated PC-based multi-channel analyzer (MCA) for recording the data. The peak area was set at a suitable range of 1–2 K to register the total spectrum [80]. The peak areas of each spectrum were evaluated by least squares fitting method using the AXIL program [81] supplied by International Atomic Energy Agency (IAEA).

**Figure 4.** (a) Geometry of the wavelength-dispersive x-ray (WDXR) spectrometry having Bragg-Brentano parafocusing optics (the abbreviations used are. SS for solar slit, FDS for fixed divergence slit, PASS for programmable anti-scattering slit, PRS for programmable receiving slit), and (b) geometry of triple axis energy-dispersive x-ray fluorescence (EDXRF) spectrometry.

## 5. Results and discussion

Compton scattering studies were carried out using photons of energy on the order of \( \times 10^2 \) keV, having scattering cross section of the order of \( 10^{-25} \) cm\(^2\)/electron. This can be calculated using the well-known expression for the cross section [25, 82]:

\[
\sigma_C = \sigma_T \frac{3}{4} \left\{ \frac{1 + \gamma}{\gamma^3} \left[ \frac{2\gamma(1 + \gamma)}{(1 + 2\gamma)} - \ln (1 + 2\gamma) \right] + \frac{\ln (1 + 2\gamma)}{2\gamma} - \frac{(1 + 3\gamma)}{(1 + 2\gamma)^2} \right\}.
\]

At the same time the total scattering cross section of this new scattering, i.e. \( \sigma_N \), derived in equation (76) and calculated to be of the order of \( 10^{-27} \) cm\(^2\)/electron, is nearly 100 times less than the \( \sigma_C \). This is one of the vital reasons for the non observance of this type of incoherent scattering peak in the earlier Compton scattering experiments. However, experimentally it seems feasible to observe this kind of scattering phenomenon using low-energy x-ray photon. For photons of energy about 10 keV (\( \gamma << 1 \)), the energy (maximum) absorbed by the excited (recoil) electron is of the order of 400 eV for scattering in the backward direction. The energy absorbed by the excited (recoil) electron is a function of the scattering angle as given in equation (16). Usually,
Thompson scattering (coherent) cross section $\sigma_T$ is of the order of $10^{-24}$ cm$^2$/electron. Since a non-relativistic (NR) description of incoherent scattering can be applied to x-rays below roughly 15 keV [83], in this energy range, the relativistic effects are negligible. Therefore, NR treatment can be applied to analyze this new scattering cross section.

The Compton cross section is of the same order as the Thompson cross section, i.e., $\sigma_C = 10^{-24}$ cm$^2$/electron in NR region [25]. In the Compton process, the total scattering cross section for 10 keV x-rays is of the order of $10^{-24}$ cm$^2$/electron. However, the $\sigma_N$ is of the order of $10^{-23}$ cm$^2$/electron, which is nearly 10 times greater than the Compton cross section in NR region. This is calculated by taking the lowest value of the momentum (velocity) ratio of electron, i.e., $\frac{p}{m}$ as 0.1. Since velocity ratio $\frac{v}{v_2}$ = $\frac{10^6}{10^2}$ ≈ 0.1, the maximum velocity attained by the excited electron (plasmon or recoil) $v_2$ due to Compton process is nearly of the order of $10^7$ m/s or less and after transferring this energy the excited electron attains a relaxed velocity $v_3$, which is same as the orbital velocity $v_1$ and is of the order of $10^6$ m/s. In actual practice, the $v_2$ is quite low hence the above velocity (or momentum) ratio is high, so a high value of scattering cross section can be observed. Again, the lifetime of plasmon excitation and the incident photon flux, which are very sensitive and bear out the idea of feasibility of this new type of scattering phenomena. The lifetime of the plasmon excitation is of the order of $10^{-16}$ s [84, 85], at the same time the lifecycle of the plasmon standing wave generated due to Compton effect (using low energy x-ray of 10 keV) calculated using de Brogile’s hypothesis is of the order of $10^{-16}$ s. Since, the number of photon emitted by the source is of the order of $10^{16}$ photon/s (as calculated in Experimental section 4.1), the possibility of this type of collision cannot be ignore. Hence, it is positive to think the experimental feasibility of such type of x-ray scattering from the plasmon standing wave whose lifecycle is few hundred times greater than the previous one (x-ray wave).

Further, the $\sqrt{\pi}$ term leads to a high value of scattering cross section from materials of high dielectric constant. As discussed, for low energy (10 keV) photons, $\sigma_N$ is on the order of $10^{-23}$ cm$^2$ per unit solid angle, and since there are roughly $10^{22}$ electrons (scatterers) per unit volume, one would expect one part in 10 of the incident beam to be scattered per cm$^3$ of sample into a unit solid angle. Observation of higher order of magnitude of the scattering cross section is justified, since our interest is on scattering of x-ray from materials of negative refractive index (virtual), where, $n_c < n_e$. Since, the experimental scattering cross section depends on both photon flux density ($I_0$) at target and number density of electron ($n_c$), i.e., \( \frac{d\sigma}{d\Omega} \)$_C$ = $\frac{Y_{corr(D)D}}{(d\Omega)D n_c I_0}$, where, $Y_{corr}$ is the corrected yield (see Appendix-B) and $(d\Omega)D$ is the detector solid angle [48]. So, with our assumption (materials of negative refractive index, $n_c < n_e$) the new scattering cross section may be given as \( \frac{d\sigma}{d\Omega} \)$_N$ = $\frac{Y_{corr}}{(d\Omega)D n_c I_0}$, when $n_c$ is the critical plasmon density where $n_c < n_e$.

Experimental existence of very low magnitude of scattering cross section such as in high-energy gamma-ray Compton scattering ($10^{-26}$ cm$^2$/sr.) [48], x-ray Raman scattering ($10^{-29}$ cm$^2$/sr.) [9, 86, 87] and proton Compton scattering ($10^{-32}$ cm$^2$/sr.) [33] has already been reported by various researchers. At the same time, electron Compton scattering cross section higher by five orders of magnitude has been reported [30].

In order to ascertain that the new modified x-ray line observed is not accidental or random one, experiments have been performed on different samples since 2000, using different x-ray wavelengths in both energy- and wavelength-dispersive spectrometers [43]. It was found that the existence of this new peak was as real and reproducible as the Compton peak and was highly dependent upon scattering angle and characteristics of the scattering substances.
5.1. WDXR spectral analysis

As discussed in the instrumental section, CoK\(\alpha\) and CuK\(\alpha\) x-ray signals are detected using a Xe-filled proportional counter. Therefore, there is possibility to detect an extra peak in the patterns observed using x-ray (Co and Cu) radiations and Xe-filled proportional counter, since CoK\(\alpha\) (6.92 keV) and CuK\(\alpha\) (8.04 keV) are both energetic enough to excite XeL\(\alpha\) (absorption edge energy 4.78 keV) and emit 4.14 keV energetic line spectra. Therefore, the spectra will contain CoK\(\alpha\) and CuK\(\alpha\) escape peaks in the respective x-ray spectrogram. The energy of these escape peaks will be simply the difference between the energy of XeL\(\alpha\) and CoK\(\alpha\) or CuK\(\alpha\), respectively. However, the escape of CoK\(\alpha\) (6.92–4.14) and CuK\(\alpha\) (8.04–4.14) arise at 2.78 keV and 3.90 keV, respectively, in the respective spectra. This well-separated keV energy peak from its incident x-ray peak arises on the low-energy side (high-angle side in WDXR spectra) after the Compton tail and can be easily identified, since the largest energy transfer in the Compton collision process is only a few hundred eV. Therefore, the new incoherent scattered peak can be well separated from the escape or spurious peak.

5.1.1. Solid PET

The organic substances are typically made up of many hydrocarbons and pose extremely difficult problem to determine the scattering factors in these condensed states, since the interference effects between molecules would be difficult to separate from the molecular structure factors. However, the Compton profile provides a method for determining the accuracy of wave functions, since there are no comparable interference effects [2, 88]. Again, these condensed states consist of low-Z elements, so the binding energy is less. Therefore, the condensed state of hydrocarbons like polymers offers opportunity to study the Compton effect by researchers. A number of works on the Compton effect in polymers have been reported [33, 40, 89–91].

The scattered spectra of CoK\(\alpha\) (6.923 keV) x-rays by a 3 mm thick and 15×25 mm\(^2\) area polyethylene terephthalate (\([C_{10}H_8O_4]_n\)) or PET target using WDXR spectrometry are shown in Figures 5(a) and (b). With an exposure of 10 h at 40 kV and 30 mA, at scattering angle 109.5° (2\(\theta\)), the spectra possess usual coherent, incoherent (Compton) peaks with a new x-ray incoherent peak at the low-angle (high-energy) side of the spectrogram. The total spectrum was collected with a scan speed of 0.00075 degree/s. The raw or smeared

![Figure 5](image-url)

**Figure 5.** (a) WDXR scattering spectra (accumulation of 10 h) of smeared intensity data obtained from PET solid at 109.5° using CoK\(\alpha\) X-radiation, and (b) the de-smeared data of the x-ray spectra showing unmodified line (r), Compton (c) and the new incoherent scattering (a) peak.
intensity was of the order of $10^6$ scattered photons and is shown in Figure 5(a). However, the de-smoed data, i.e., after subtracting background is shown in Figure 5(b). The wavelength shift of the Compton peak, which varies with the scattering angle $2\theta$ (109.5°), was calculated to be about 0.0327 Å and is given in Table 1.

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<td>$E_p^e$/eV</td>
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<td>$E_B^e$/eV</td>
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</tr>
<tr>
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<td>$I_c/I_r$</td>
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<tr>
<td>$q'/a.u$ (43)</td>
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<td>$I_a/R_c$</td>
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</tr>
<tr>
<td>$\Delta \lambda_c$/Å (25)</td>
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<td>$k_p$/Å$^{-1}$ (76)</td>
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</tr>
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<td></td>
<td>0.0324 ± 0.0001 (T)</td>
<td></td>
<td>5.81 ± 0.01 (T)</td>
</tr>
<tr>
<td>$\Delta \lambda_N$/Å (10)</td>
<td>0.0320 ± 0.0002 (E)</td>
<td>$\sigma N/10^{-24}$ (76) cm$^2$/electron</td>
<td>44.88 ± 2.76 (E)</td>
</tr>
<tr>
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<td>0.0324 ± 0.0002 (T)</td>
<td></td>
<td>42.50 ± 2.43 (T)</td>
</tr>
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</table>

Using the relation $\frac{v}{c} = \frac{1}{\gamma} Z_{eff}$ [F. K. Richtmyer, E. H. Kennard, and J. N. Cooper, *Introduction to Modern Physics*, 6th Ed., p. 236, Tata McGraw-Hill Publishing Company Ltd. New Delhi, 1976], can be obtained by simplifying the fine structure constant for the complex material.

The effective atomic number, $Z_{eff} = \frac{2.94}{\sqrt{f_1 \times (z_1)^{2.94} + f_2 \times (z_2)^{2.94} + f_3 \times (z_3)^{2.94} + \ldots}}$.

Electron density (electrons/cm$^3$) of the material can be calculated using the approximate relation, $n_e = Z_{eff} \frac{N_A \rho}{M}$, where $N_A$ is the Avogadro’s number $(6.023 \times 10^{23})$, $\rho$ is the density, and $M$ is the molecular weight of the complex.

Plasmon energy (eV) of the complex system can be calculated using the relation $E_p = \left[ \frac{\hbar}{m} \left( \frac{4\pi e^2}{m} \right)^{1/2} \right]^{1/2} (n_e)^{1/2} = 3.711 \times 10^{-11} \sqrt{\sigma_e}$.

Average binding energy of carbon 1s (PET) published in the paper [77].

As stated in the hypothesis, during Compton process the material target behaves as a virtual metamaterial, the NRI of PET ($\varepsilon = 3.4$) was estimated to be -0.52 (using expression (6)). Due to the NRI of the target material, x-rays of low frequency were scattered with high frequency (low wavelength). Wavelength shift in this process is found to be 0.0320Å experimentally for the PET, which matches well with the theoretically (using expression (10)) calculated value and is given in the Table 1. The intensity ratio (de-smoed data) of the modified (Compton) to unmodified, i.e., $I_a/I_r$ ($=R_c$) was found out to be 1.479. However, the Compton peak-to-background ratio obtained was about 68:1. It is interesting to note that a low-intensity peak of about 26.5% of the height of the Compton peak with the standard deviation, $\sigma$ [70, 92] of 1.57% was visible on the high-energy side (with respect to coherent peak) of the spectra measured on PET. Intensity ratio of the above new incoherent peak $I_a$ with usual unmodified peak$I_r$, i.e., $I_a/I_r$ was found to be 0.394 (peak-to-background
ratio is 18:1). The position of this new peak corresponded to an energy transfer of about 123 eV (high energy side of the CoKα line), whose Compton shift energy of about 138 eV (low energy side of the CoKα line). However, the C1s binding energies of PET are 284.4 eV (benzene ring), 286 eV (-CH2-O-) and 288.5 eV (-CO-O-) [93].

It is interesting to note that the Compton profile J(q) from these 1s electrons was too weak to be observed, since the energy loss in the Compton process Δℏω is less than the binding energy of the electron EB. This ground state energy with 1s hydrogenic wave function at its initial-state can be written as

$$E_B = \frac{Z^2 m e^2}{2 \hbar^2}$$

[2]. The effective atomic number Zeff, of the complex material (PET) can be calculated using the methods known as “self-consistent field (SCF)” or Hartree-Fock (HF) method, but in simplified situation

$$Z_{eff} = f_1 \times (z_1)^{2.94} + f_2 \times (z_2)^{2.94} + f_3 \times (z_3)^{2.94} + \cdots$$

where $f_1$ is the fraction of the total number of electrons associated with each element and $z_n$ is the atomic number of each element in the complex material [94]. Hence, the ground state velocity of the electron in terms of velocity of light was calculated to estimate the peak broadening. The energy spread of the new peak, i.e., width (38 eV) found out to be less than the Compton profile width (78 eV). Taking width of the profile into consideration, the energy of the incoherently scattered photon of Compton type (equation (24)) was found out to be 6.874 keV and energy of the new x-ray photon (equation (40)) is about 7.008 keV.

It was under these scattering conditions (CoKα radiation and 2θ = 109.5°), the profile functions q and q′ were calculated for both types of scattering process. The value of q and q′ was found out to be +0.952 a.u. and +0.454 a.u., respectively. The negative sign of the expression (33) implies that for positive q value the energy shift is lower. Therefore, smaller the positive value of q, smaller will be the energy shift. Hence, the less positive value of q′ (expression (43)) with respect to q (expression (33)) indicates that the energy exchange in the new process is lower as compared to the Compton process. The momentum transfer $k_p$ in this process is found out to be 5.71 ± 0.02 Å−1. The total scattering cross section $\sigma_N$, which is inversely proportional to the third power of the $k_p$ (equation (76)), is found to be $(44.88 \pm 2.76) \times 10^{-24}$ cm²/electron. This is very close to the theoretically calculated result $(42.50 \pm 2.43) \times 10^{-24}$ cm²/electron, and is given in the Table 1. Again, $\sigma_N$ is directly proportional to $\sqrt{\varepsilon}$ as given in equation (76), which indicates that the materials of high value of dielectric constant produces high value of $\sigma_N$.

Most polymers possess very low value of static dielectric constant; this can be further enhanced in various ways. One of the important ways for enhancing the static dielectric constant (impurity free) of the polymer is by treating the polymer with proton beam [95–97].

5.1.2. Liquid glycerin

CuKα (8.048 keV) x-ray scattered from 2 mm thick pure glycerin (C3H8O3) shows the existence of this new peak. The sample was packed in a special-type liquid cell (25 × 30 mm²) having 3 micron Mylar window at both sides. With an exposure of 10 h at 30 kV and 20 mA at scattering angle 108.5°, and effective area of 83 mm², the total spectrum was collected with a scanning speed of 0.00112 °/s. Intensity of the raw data was on the order of $10^4$ scattered photons and the smeared intensity was about a few hundred counts from the liquid target, as shown in Figure 6. Though difficult, it is very interesting to analyze the gaseous and liquid samples [98, 99]. The Compton effect of other high-dielectric liquid-like water has been well studied [37, 100–104]. Because of the presence of carbon atom, high dielectric ($\varepsilon = 68$) nature, and availability in its pure form, glycerin was selected for the present study.
Table 2 shows the results of the glycerin-CuK\(_{\alpha1}\) scattered-profile. The wavelength shift of the Compton peak was calculated to be about 0.0285 Å. Since the dielectric constant is very high (about 68.2), the NRI was estimated to be -2.33. Because of very low NRI value, x-ray of low frequency scattered with high frequency (low wavelength). Experimental wavelength shift in this process is found to be 0.0296 Å. The intensity ratio of the modified (Compton) to unmodified peak, \(I_c/I_r\) \(= R_c\) was found out to be 1.629. A low-intensity peak similar to the peak found on the scattered profile of PET was observed with accuracy corresponding to 36.9 ± 2.05 % of the height of the Compton peak. The Compton peak-to-background ratio obtained was about 80:1. However, the ratio of this new peak-to-background is 35:1. Intensity ratio of the above new peak with usual unmodified peak \(I_o/I_r\) was found to be 0.663. The position of this new peak corresponded to an enhanced energy of about 140 eV with respect to the CuK\(_{\alpha1}\) line, whose Compton shift was about 163 eV. However, the electronic binding energies of glycerin are 286.1 eV (C 1s) and 532.2 (O 1s) [105]. Experimentally, the width of the Compton profile (116 eV) was found out to be more than the new incoherent profile (50 eV). The incoherently scattered photon energies \(\hbar\omega_2\) and \(\hbar\omega_3\) are found out to be 7.994 keV and 8.162 keV, respectively. The profile functions \(q\) and \(q'\) were calculated for both types of scattering process and were found out to be +1.219 a.u. and +0.519 a.u., respectively. This confirms that the energy exchange in the new process is lower as compared to the Compton process. The small momentum transfer \(k_p\) in this process is found out to be 6.60 ± 0.04 Å\(^{-1}\). This gives a total scattering cross section \(\sigma_N\) of about \((139.74 ± 1.81) \times 10^{-24}\) cm\(^2\)/electron, which matches well with the theoretically calculated value \((129.93 ± 0.81) \times 10^{-24}\) cm\(^2\)/electron). The high value of scattering cross section as compared to the PET sample is because of its high dielectric constant. This is one of the key parameters to observe this type of incoherent scattering phenomena, since the total scattering cross section is directly proportional to \(\sqrt{\varepsilon}\) as given in equation (76).

5.2. EDXRF spectral analysis

Secondary x-ray of two different energetic lines PbL\(_{\alpha}\) and MoK\(_{\beta}\) were used to obtain sufficiently extended scattering data. As discussed earlier, the actual interest of the study is on scattering of low-energy x-rays energy (<15 keV) in the non-relativistic region from the materials. X-rays of K, L and M lines of a particular element
show a decreasing order of energy and FWHM. From the table [46] related to wavelength of the spectral line of important target metals and their respective spectral line width, it is clear that the AgL x-ray lines are having the highest spectral resolution (FWHM/λ) and the PbL shows the next to the AgL lines. However, the PbL x-ray was selected to carryout the scattering experiment for many reasons. Firstly, the wide energy spacing between the two nearby PbL x-ray lines, i.e., the energy spacing between PbL\(_\alpha\)-PbL\(_\beta\) or PbL\(_\beta\)-PbL\(_\gamma\) is around 2.1 keV. Hence, the incident x-ray lines (PbL\(_\alpha\), PbL\(_\beta\), PbL\(_\gamma\)), their respective Compton lines, SiK\(_\alpha\)-escape peaks (from the Si(Li) detector) and the new incoherent line can be well separated. Nevertheless, the energy spacing between AgL\(_\alpha\)-AgL\(_\beta\) or AgL\(_\beta\)-AgL\(_\gamma\) is around 270 eV. Secondly, these x-ray lines (PbL x-ray lines) belongs to the non-relativistic photon (<15 keV) of maximum energy. Therefore, the maximum energy loss in the Compton collision process in a back scattering geometry is around 800 eV, which is expected to produce well-intense and well-separated peak for lighter elements (smaller Z).

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<td></td>
<td>0.0320 ± 0.0001 (T)</td>
<td></td>
<td>6.76 ± 0.04 (T)</td>
</tr>
<tr>
<td>(\Delta\lambda_N/\text{Å})</td>
<td>0.0296 ± 0.0003 (E)</td>
<td>(\sigma_N/10^{-24}) (76)</td>
<td>139.74 ± 1.81 (E)</td>
</tr>
<tr>
<td></td>
<td>0.0320 ± 0.0003 (T)</td>
<td>(\text{cm}^2/\text{electron})</td>
<td>129.93 ± 0.81 (T)</td>
</tr>
</tbody>
</table>

\(a\) Binding energy of 1s carbon and oxygen present in glycerin published in the paper (Krebs et al., 2007).

5.2.1. Graphite

Pressed graphite powder pellet of 3 mm thick and 30 mm diameter was used to study the scattering profile of PbL x-rays. Data were collected at a 125° scattering angle and the running time of the total spectrum was about 20 h. The PbL x-ray [106, 107] spectrum scattered from graphite is shown in Figure 7(a). The PbL\(_\alpha\) x-ray intensity of the Compton scattered photons was of the order of 1.5 \(\times\) 10\(^4\). However, graphite has been widely studied by various researchers [1, 2, 7, 9, 108–111] because of its small atomic number, low binding energy, simplicity, nontoxicity, low-price, and readily availability. As in earlier wavelength-dispersive
scattered-profiles (PET and glycerin), incoherent scattering peak of higher energy as compared to the incident PbL\(_{\alpha}\) line of energy 10.5005 keV (channel number 806) was also observed.

![Graph showing EDXRF spectra](image)

**Figure 7.** (a) Full EDXRF spectra (accumulation of 20 h) obtained from graphite pellet using PbL\(_{\alpha}\) x-rays scattering at 125°, and (b) the enlarged part of the same spectra showing unmodified PbL\(_{\beta}\) line (r), Compton (COMP) and the new-type incoherent scattering (NEW) line.

The energy shift of the Compton peak was calculated to be 325 eV with an average energy spread of about 13.03 eV per channel. The NRI of graphite (\(\varepsilon = 12.15\)) was calculated and found out to be -0.977. Experimental energy shift in this process is found to be 300 eV, which is less than the energy absorbed in Compton process and is given in Table 3.

The intensity ratio of the modified (Compton) to unmodified peak, i.e., \(I_c/I_r\) \((=R_c)\) was found out to be 1.501. The Compton peak-to-background ratio obtained was about 403:1. A very low-intensity peak (at channel no. 829) of the new incoherent line followed by Si-ESC (PbL\(_{\beta}\)) was observed (incident PbL\(_{\beta}\) line of energy 12.618 keV occurs at channel no. 988), as shown in Figure 7(b). The peak-to-background ratio of the above line is about 39:1, with an accuracy corresponding to 9.5 ± 0.09 % of the height of the Compton peak. Again, the low-intensity PbL\(_{\alpha}\) line of energy 11.349 keV [107] was observed at channel number 870, just after the Si-ESC (PbL\(_{\beta}\)) line. Intensity ratio \(I_a/I_r\) was found to be 0.057, which is quite less as compared to the CoK\(_{\alpha}\) and CuK\(_{\alpha}\) x-rays because of the greater photon emitting capacity of the high-power seal-off tube. This is because of the fact that PbL\(_{\alpha}\) line is relatively more energetic then those x-rays. The peak is not an escape peak of the silicon (detector), since the energy displacement of the SiK\(_{\alpha}\) escape peak from its incident x-ray peak is generally reported to be 1.740–1.755 keV [112, 113]. Again, the intensity ratio of escape peak to total peak is reported to be \(4.4 \times 10^{-3}\) [113]. The incoherently scattered photon energies \(\hbar\omega_2\) and \(\hbar\omega_3\) are found out to be 10.283 keV and 10.753 keV, respectively. Both the profile functions \(q\) and \(q'\) were calculated and were found out to be +0.858 a.u. and +0.692 a.u., respectively, which confirms that the energy exchange in the new process is lower as compared to the Compton process.

The small momentum transfer \(k_p\) in this process is found out to be 9.73 ± 0.03 Å\(^{-1}\). This gives a total scattering cross section \(\sigma_N\) of about \((320.44 ± 1.15) \times 10^{-24}\) cm\(^2\)/electron, which matches well with the
Table 3. Analysis of PbLα x-ray scattered profile from the graphite powder applying EDXRF spectrometry. The factors used for the conversion of wavelength (Å) and energy (keV) is \( \lambda (\text{Å}) = \frac{12372}{E \text{(keV)}} \).

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Experimental value</th>
<th>Parameter</th>
<th>Experimental value</th>
</tr>
</thead>
<tbody>
<tr>
<td>( \gamma )</td>
<td>0.021</td>
<td>( \varepsilon )</td>
<td>12.15</td>
</tr>
<tr>
<td>( \beta /^\circ )</td>
<td>125</td>
<td>( n ) (6)</td>
<td>( \pm 0.977 )</td>
</tr>
<tr>
<td>( v/c )</td>
<td>0.044</td>
<td>( Z_{\text{eff}} )</td>
<td>6</td>
</tr>
<tr>
<td>( \lambda /\text{Å} )</td>
<td>1.18075</td>
<td>( n_e /10^{22} \text{e/ cm}^3 )</td>
<td>67.2</td>
</tr>
<tr>
<td>( h\omega_1 /\text{keV} )</td>
<td>10.5005</td>
<td>( E_p /\text{eV} )</td>
<td>30.42</td>
</tr>
<tr>
<td>( h\omega_2 /\text{keV} ) (24)</td>
<td>10.283</td>
<td>( E_B /\text{eV} )</td>
<td>284.2 (C1s)</td>
</tr>
<tr>
<td>( h\omega_3 /\text{keV} ) (40)</td>
<td>10.753</td>
<td>( I_a /I_r )</td>
<td>0.057</td>
</tr>
<tr>
<td>( q /\text{a.u.} ) (33)</td>
<td>+0.858</td>
<td>( I_c /I_r )</td>
<td>1.501</td>
</tr>
<tr>
<td>( q' /\text{a.u.} ) (43)</td>
<td>+0.692</td>
<td>( I_a /R_c )</td>
<td>298</td>
</tr>
<tr>
<td>( \Delta h\omega /\text{eV} ) (13)</td>
<td>325 ( \pm 2.45 ) (E)</td>
<td>( k_p /\text{Å}^{-1} ) (76)</td>
<td>9.73 ( \pm 0.03 ) (E)</td>
</tr>
<tr>
<td></td>
<td>329 ( \pm 0.88 ) (T)</td>
<td></td>
<td>9.76 ( \pm 0.03 ) (T)</td>
</tr>
<tr>
<td>( \Delta h\omega</td>
<td>_N /\text{eV} ) a</td>
<td>300 ( \pm 4.59 ) (E)</td>
<td>( \sigma_N /10^{-24} ) (76)</td>
</tr>
<tr>
<td></td>
<td>328 ( \pm 9.23 ) (T)</td>
<td>( \text{cm}^2/\text{electron} )</td>
<td>315.74 ( \pm 1.15 ) (T)</td>
</tr>
</tbody>
</table>

a Theoretically the amount of energy transferred to x-ray photon by excited electron can be given in the energy dispersive relation \( \Delta h\omega|_N = h\omega_3 - h\omega_1 = \left( \frac{12372}{\lambda - \Delta \lambda N} \right) - h\omega_1 \), where \( \Delta \lambda N \) can be calculated using equation (9).

b The binding energy of carbon 1s [49].

Theoretically calculated value ((315.74 \( \pm 1.15 \)) \times 10^{-24} \text{ cm}^2/\text{electron}). Since energy of the PbLα line is high as compared to CoKα1 line, one would expect low value of \( \sigma_N \) for PbLα line. However, higher value \( \sigma_N \) for PbLα line scattered from graphite is because of its high electron density \( (10^{23} \text{ electron/cm}^3) \) and relatively high dielectric constant as compared to PET solid.

5.2.2. Single crystals (NaCl, MgF₂)

MoK radiation (secondary x-ray) based EDXRF system was used to analyze the single crystals and the pressed powder. The same graphite sample, which was studied using PbL x-rays, was also used. The single crystal slices of NaCl (100) and MgF₂ (110), about 3 mm thickness and 30 mm diameter, were used. The full spectrum of MoK radiation scattered at 90° from pressed-powder graphite pellet is shown in the Figure 8(a). In addition, MoK x-rays scattered at 90° from both the single crystals. Since there is no x-ray line after the MoKβ₁ (20 keV) radiations, so this line was selected for analysis of the scattered-profile for the entire sample and is shown in Figure 8(b). The running time of the total spectrum of graphite was about 10 h, which produces intensity of MoKα-Compton line is of the order of \( 10^5 \) scattered photons. However, the running time for the NaCl and MgF₂ single crystals were about 8 h each. A very low-intensity peak was observed at channel no. 618, which is about < 1 % of the height of the Compton peak. The lowest background of 610 counts was obtained at channel no. 236. For the MoKβ₁ x-rays, the Compton peak-to-background ratio is about 81:1. Intensity ratio with respect to unmodified (MoKβ₁) line, i.e., \( I_a/I_r \) was found to be very less, which is nearly 15 times less than the PbLα line. This is because of the fact that MoKβ₁ (19.608 keV) line is relatively more energetic than the PbLα (10.5005 keV) line. Experimental energy shift \( \Delta h\omega \) in the Compton scattering was found out to be
724 eV with energy spread of about 32.85 eV per channel and for the new process, the shift \( \Delta \hbar \omega |_N \) is about 689 eV. Since energy of the incident-photon (MoK\( \beta_1 \)) is greater than 15 keV, the relativistic effect comes into picture. The width of the Compton profile \( w_C \) is estimated to be less as compared to the profile \( w_N \) of new incoherent peak. Hence, for high-energy incident photon, the width of the profile becomes large with decreased intensity; therefore, the peak vanishes. This is another reason why this type of incoherent peak is not detected by the researchers working on Compton scattering using high-energy x-ray photons. Similarly, more energetic (as compared to the incident MoK\( \beta_1 \) line) and very low-intensity scattered peak was also observed from the NaCl (channel no. 618) and MgF\(_2\) (channel no. 620) single crystals. However, detailed Compton scattering studies of NaCl [114, 115] and MgF\(_2\) [116, 117] have been reported elsewhere.

![Figure 8](image-url)

From the above studies on interaction of radiation with target materials, it was observed that this new x-ray effect can be observed using photons of energy of the order of 10 keV. A theoretical plot of energy shift \( \Delta \hbar \omega |_N \) with scattering angles by 10 keV photons is shown in Figure 9(a). The maximum energy shift \( \Delta \hbar \omega |_N \) at highest scattering angle 180° is about 300 eV. Again, the intensity ratio of modified (Compton) to unmodified peak, i.e., \( I_c / I_r \) (\( = R_c \)) is inversely proportional to the electronic binding energy of the material. The intensity ratio of new modified peak (at scattering angle around 90°–110°) with respect to \( R_c \) (selected to prevail over the effect of intensity ratio due to electronic binding energy of different materials), i.e., \( I_a / R_c \) increases with increase in NRI value, as shown in Figure 9(b). This confirms that the material having high NRI value possesses more prominent peak. Again, the intensity ratio of new modified peak (in a carbon system) with respect to unmodified peak, i.e., \( I_a / I_r \) decreases with increase in photon energy, as shown in Figure 9(c). A theoretical plot of differential scattering cross section \( \left( \frac{d \sigma}{d \Omega} \right)_N \) for maximum scattering angle (180°) from a graphite system was plotted using x-ray photons of energy up to 100 keV, as shown in Figure 9(d). For 10 keV and 100 keV photon the theoretical cross section was calculated to be \( 2.187 \times 10^{-23} \) cm\(^2\)/sr and \( 2.187 \times 10^{-27} \) cm\(^2\)/sr respectively. On the other hand, comparison with Compton cross section, the new cross sections \( \sigma_N \) at 10 keV
and 100 keV are found out to be $10\sigma_C$ and $\sigma_C/100$ respectively. The experimental $(\frac{d\sigma}{d\Omega})_N$ values of the PbL$_\alpha$ (10.5005 keV) line and MoK$_{\beta 1}$ (19.608 keV) line scattered by graphite and marked as dark-circle were also plotted. Both theoretically calculated and experimentally observed data match well with each other. A small deviation in the experimental data point of about 20 keV is because of the low scattering angle ($2\theta = 90^\circ$).

![Graph](image)

**Figure 9.** (a) Scattering angle $(2\theta)$ versus amount of energy enhanced by x-ray (10 keV) scattering at 180° from graphite in the new scattering process, (b) NRI ($-n$) versus $I_a/R_c$ of materials of different dielectric constants, (c) incident photon energy versus $I_a/I_r$ in high carbon materials, and (d) incident photon energy (1–100 keV) versus differential scattering cross section of the new scattering phenomena.

Usually, x-ray scattering from plasmon appears clearly under the condition that $k$ is smaller than a critical wave vector $k_c$, i.e., $k < k_c$. As the case of the dielectric of our interest, $\varepsilon(\omega, k) < 0$ (where $\omega$ is real}
and $k$ is imaginary), the wave is damped with a characteristic length $1/|k_c|$ (plasmon cut-off vector). Higher value of this traditional plasmon cut-off wave vector $k_c (= 0.47 \times \sqrt{\frac{\mu}{r_s}} k_F)$ has been reported in Srivastava [118]. Indeed, x-ray scattering from plasmon with $k > k_c$ has been experimentally observed [58, 59, 119]. This large value of the damping constant is because of quadratic dispersion of RPA Lindhard type dielectric constant [120]. In addition, the plasmon dispersion curve bent over for larger values of $k$ and showed little dependence of $\omega$ and $k$. This region of little dispersion occurred for $k$ values well beyond $k_c$ [119]. This is why the dynamic dielectric function $\varepsilon(\omega, k)$ replaced in terms of static dielectric constant $\varepsilon$ in equation (68). Hence, experimental observation of high value of $k_p$, i.e., $k_p > k_c$, in the final expression for the scattering cross section (76) is logical.

The relatively low-energetic x-rays used in this study limit the analysis of advance material systems like quantum dots [121], superconductors [122], disordered alloys [123–127], ferromagnetic amorphous alloys [128], and mixed crystals [129], as analyzed using the high-energy Compton scattering experiment. Also, the researchers of our Institute have been reported a number of good works on Compton profile and electron momentum density studies of many advance material systems for last three decades [114, 116, 129–133]. Hence, at low photon energies the “impulse-approximation” approach [134], which requires the energy transfer in the scattering process to be large, compared to the $E_B$ involved, ceases to be valid for high-Z atoms. Again, the properties of electrons in solids can be better understood in the region of smaller energy and momentum transfer, since x-ray Compton spectra are very sensitive to band structure near the Fermi level. Hence, the new x-ray effect may give better understanding about the solid-state physics of the material and it is expected that this new effect will give a new dimension to understand the electronic structure of materials in general using the Compton effect.

6. Conclusion

In the present paper, theoretically predicted and experimentally observed new modified x-ray peak having the following major features has been reported: (i) the new modified peak is slightly less wide than the Compton peak because the modified peak width decreases with increase in frequency and strongly depends on scattering angle and amount of energy transfer; (ii) energy of the new modified peak is greater than that of Compton peak for the same incident x-rays; (iii) energy shift in this collision process is less than the shift by Compton process; and (iv) high value of total scattering cross section $\sigma_N$ was obtained from materials of high dielectric constant and low binding energy on applying low-energy x-rays.

It has been reported that the Compton spectrometers have the best momentum resolution typically operated at about 10 keV, which means that the energy transferred to the Compton electron is of the order of 1 keV (i.e., the same order of magnitude as the binding energies of inner-shell electrons of light elements) [135]. It is expected that, with the use of relatively less harder x-rays, high-intensity x-ray source (synchrotron), x-ray detectors of excellent energy resolution [136, 137], position-sensitive detector [74, 108], imaging plate [74], suitable scattering angles (considering the plasmon scattering at $n_c < n_e$) [84] and materials (possessing low atomic number, high dielectric constant or metamaterials), it may be possible to get more prominent new modified peak with better signal-to-noise ratio. The instrument required for this purpose should be sensitive (Compton effect) to the polarization of x-ray considering all the geometrical factors.

Where polarization sensitivity of the device is a measure of asymmetry parameter $A$, and is a function
of asymmetry ratio $R$ (ratio of cross sections) and $N_R$ (ratio of coincidence counting rates) for high-energy Compton scattering study [138–141]. However, asymmetry parameter of low energy x-ray is given elsewhere [142, 143]. Therefore in the present WDXR instrument, the values of $A$ are estimated as $0.037 \pm 0.002$ (CoK$_\alpha$) and $0.046 \pm 0.002$ (CuK$_\alpha$), using the theory suitable for the asymmetry of Thomson scattering spectrum (since Compton effect is less prominent in case of low energy x-ray) [143].

Similarly, for the EDXRF instruments, estimated values of $A$ are $0.037 \pm 0.003$ (PbL$_\alpha$) and $0.026 \pm 0.002$ (MoK$_\beta$) respectively. Advanced spectrometers such as dispersion-compensating [144] scanning x-ray spectrometer with high flux (in the order of $10^{11}–10^{12}$ photons/second) [145, 146], Cauchois-type x-ray spectrometer [147, 148], high resolution Compton spectrometer operated in the Rowland circular geometry [145] or better x-ray spectrometer for inelastic scattering [75, 149] are the right choice to carry out the studies. The inverse photoelectric effect (production of x-rays), the inverse Compton effect and the inverse Raman effect are the experimental processes for the production of new radiation, whereas anti-Stokes scattering is due to material mechanism, therefore the name of the new phenomenon may be proposed as anti-Compton scattering [43]. This new x-ray scattering can be applied for calculation of excited volume plasmon energy of materials [11], electron dynamics [150], or electron charge and spin density [151], valence-electron component of the atomic scattering factor [152], usual incoherent and coherent differential scattering cross-sections [153] within the same line as Compton effect, as well as for characterizing electroactive polymers, i.e., polymers of high-dielectric constant [154] and organic liquids, and for designing x-ray laser.

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Appendix A

The evaluation of the matrix element occurring in equation (55) requires multiplying $E' + (m_0c^2 + k_1)$ with numerator and denominator of the 1st term of $M$, i.e., $M_1$. Using the wave equation,

$$E' u' = [(\alpha_i p') + \beta m_0 c^2] u' = H' u'$$

where $\alpha_i$, $\beta$ are usual Dirac Matrices and $p'$ is, of course, constant for the summation $\sum$:

$$|M_1| = \sum u' \left( u^* \alpha u' \right) \left( u^* \alpha_0 u_0 \right) \frac{(m_0 c^2 + k_1 + E')}{E'^2 - (m_0 c^2 + k_1)^2}$$

$$|M_1| = \sum \left( m_0 c^2 + k_1 \right) \left( u^* \alpha u' \right) \left( u^* \alpha_0 u_0 \right) + \sum \left( u^* \alpha H' u' \right) \left( u^* \alpha_0 u_0 \right)$$

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Applying the general formula

\[ \sum^{p'} (u_0' Q_1 u') (u'' Q_2 u) = (u_0' Q_1 Q_2 u) \]  \hspace{1cm} (A4)

and \( E'^2 = p'^2 + (m_0c^2)^2 = k_1^2 + (m_0c^2)^2 \), then

\[ |M_1| = \left[ \frac{2k_1}{m_0c^2} \right] \left[ (m_0c^2 + k_1) (u^* \alpha \alpha_0 u_0) + (u^* \alpha H' \alpha_0 u_0) \right]. \]  \hspace{1cm} (A5)

Similarly, the 2\textsuperscript{nd} term of \( M \), i.e., \( M_2 \) can be simplified using \( E''^2 = p''^2 + (m_0c^2)^2 = k_3^2 + (m_0c^2)^2 \) as

\[ |M_2| = \left[ \frac{2k_3}{m_0c^2} \right] \left[ (m_0c^2 + k_3) (u^* \alpha \alpha_0 u_0) + (u^* \alpha H'' \alpha_0 u_0) \right]. \]  \hspace{1cm} (A6)

**Appendix B**

Experimentally observed scattering intensity or the corrected yield \( Y_{corr} \) and can be defined as

\[ Y_{corr} = n_p \sigma N_v l \frac{1}{\phi_s} \frac{1}{\phi_d} \frac{1}{\phi_{air}}, \]  \hspace{1cm} (B1)

where \( n_p \) is the number of primary photon incident on the target, \( \sigma \) is the cross section, \( N_v \) is the number of atoms or molecules per cm\(^3\), \( l \) is the sample thickness, \( \phi_s \) is the self absorption factor in the target, \( \phi_d \) is the detector efficiency and \( \phi_{air} \) is the air absorption in the air column between detector window and target.

Applying quantum mechanical Klein-Nishin formula, the sensitivity of the Compton effect to the polarization of an incident x-ray can be estimated from the asymmetry parameter \( A \), which is defined as

\[ A = \frac{(1 - N_R R)}{(N_R - R)} \]  \hspace{1cm} (B2)

where \( N_R = N_{\chi=90^\circ}/N_{\chi=0^\circ} \), is the ratio of the coincidence counting rates with the instrument set at angle \( \chi \) and \( R = d\sigma_{\chi=90^\circ}/d\sigma_{\chi=0^\circ} \) is the ratio of Compton scattering cross sections or asymmetry ratio and is given elsewhere [138].

However, for low energy x-ray the asymmetry parameter [143] of the Thomson scattering spectrum is given as

\[ A = (v/c) \cos \phi, \]  \hspace{1cm} (B3)

where \( \phi \) is the angle between Compton recoil electron and scattered x-ray vector.
References


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